N-Channel 100 V (D-S) MOSFET

PRODUCT SUMMARY $R_{DS(on)}(m\Omega)(Typ.)$ Q_g (Typ.) V_{DS} (V) ID (A)a 11 at $V_{GS} = 10 \text{ V}$ 100 48 21.3 nC 15 at $V_{GS} = 4.5 \text{ V}$

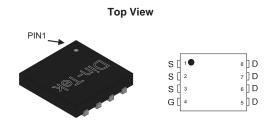
FEATURES

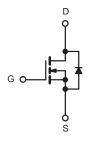
- DT-Trench Power MOSFET
- $\bullet\,$ 100 % $\rm R_{\rm g}$ and UIS Tested
- Low Gate Charge
- · Logic Level Driven

APPLICATIONS

- · AC-DC/DC-DC Converter
- · Cell Phone Quick Charger

PDFN3.3X3.3-8L Pin Configuration





N-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS (T _C = 25 °C, unless otherwise noted)					
PARAMETER		SYMBOL	LIMIT	UNIT	
Drain-Source Voltage		V _{DS}	100	V	
Gate-Source Voltage		V_{GS}	± 20	V	
Continuous Drain Current (T _J = 150 °C) ^a	T _C = 25 °C	- I _D	48	А	
	T _C = 100 °C		36.5		
Pulsed Drain Current ^b		I _{DM}	178		
Single Avalanche Energy		E _{AS}	175	mJ	
Maximum Power Dissipation ^c	T _C = 25 °C	P _D	84	W	
	T _C = 100 °C		32.1		
Operating Junction and Storage Temperature Rar	nge	T _J , T _{stg}	- 55 to + 150	°C	

THERMAL RESISTANCE RATINGS					
PARAMETER		SYMBOL	LIMIT	UNIT	
Junction-to-Ambient (PCB Mount) d	t ≤ 10 s	R _{thJA}	22	°C/W	
Junction-to-Case (Drain)	Steady State	R _{thJC}	1.78	C/VV	

Notes

- a. Calculated continuous current based on maximum allowablejunction temperature.
- b. Repetitive rating; pulse width limited by max. junction temperature.
- c. $\,$ Pd is based on max. junction temperature, using junction-case thermal resistance.
- d. The value of R_{0JA} is measured with the device mounted on 1 in 2 FR-4 board with 2oz. Copper,in a still air environment with Ta=25 °C.



PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT	
Static							
Drain-Source Breakdown Voltage	V_{DS} $V_{GS} = 0 \text{ V}, I_D = 250 \mu A$		100	-	-	V	
Gate Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_D = 250 \mu A$	1	-	3	7 °	
Gate-Body Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$	-	-	± 100	nA	
Zero Gate Voltage Drain Current		V _{DS} = 100 V, V _{GS} = 0 V	-	-	1	<u>μ</u> Α	
	I _{DSS}	$V_{DS} = 80 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 125 ^{\circ}\text{C}$	-	-	100		
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	48	-	-	Α	
Drain-Source On-State Resistance ^a	D ·	$V_{GS} = 10 \text{ V}, I_D = 10 \text{ A}$	-	11	15	mΩ	
	R _{DS(on)}	V _{GS} = 4.5 V, I _D = 8 A	-	15	23		
Forward Transconductance ^a	9 _{fs}	$V_{DS} = 5 \text{ V}, I_{D} = 10 \text{ A}$	-	35	-	S	
Dynamic ^b							
Input Capacitance	C _{iss}		-	1320	-	pF	
Output Capacitance	C _{oss}	$V_{GS} = 0 \text{ V}, V_{DS} = 50 \text{ V}, f = 1 \text{ MHz}$	-	348	-		
Reverse Transfer Capacitance	C _{rss}		-	5	-		
Total Gate Charge ^c	Qg		-	21.3	-	nC	
Gate-Source Charge ^c	Q _{gs}	$V_{DS} = 50 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 10 \text{ A}$	-	3.05	-		
Gate-Drain Charge ^c	Q _{gd}		-	3.9	-		
Gate Resistance	R_g	f = 1 MHz	-	1.3	-	Ω	
Turn-On Delay Time ^c	t _{d(on)}		-	12	-		
Rise Time ^c	t _r	$V_{DD} = 50 \text{ V}, I_D = 10 \text{ A}, R_g = 2\Omega$	-	8	-	ns	
Turn-Off Delay Time ^c	t _{d(off)}	V _{GS} = 10 V	-	30	-		
Fall Time ^c	t _f		-	6	-		
Drain-Source Body Diode Ratings and	Characterist	ics ^b (T _C = 25 °C)					
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C	-	-	48	Α	
Pulsed Current	I _{SM}		-	-	178	Α	
Forward Voltage ^a	V _{SD}	I _F = 1 A, V _{GS} = 0 V	-	-	1.2	V	
Reverse Recovery Time	t _{rr}	L = 10 A di/dt = 100 A/···	-	25	-	ns	
Reverse Recovery Charge	Q _{rr}	$I_F = 10 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s}$	-	90	-	nC	

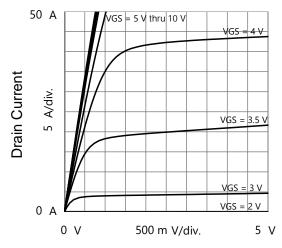
Notes

- a. Pulse test; pulse width \leq 300 µs, duty cycle \leq 2 %.
- b. Guaranteed by design, not subject to production testing.
- c. Independent of operating temperature.

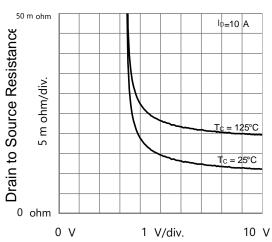
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those in dicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended pe riods may affect device reliability.



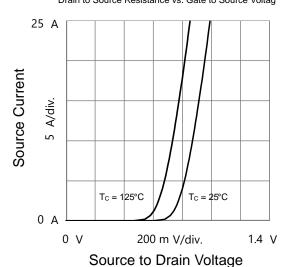
TYPICAL CHARACTERISTICS (T_C = 25 °C, unless otherwise noted)



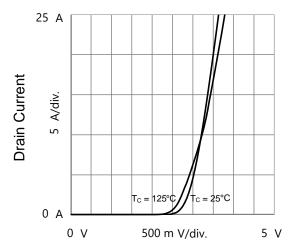
Drain to Source Voltage Output Characteristics



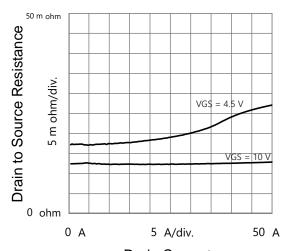
Gate to Source Voltage
Drain to Source Resistance vs. Gate to Source Voltag



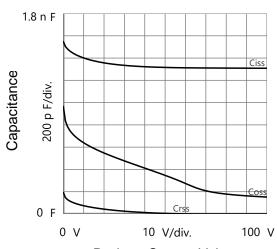
Body Diode Forward Characteristics



Gate to Source Voltage Transfer Characteristics



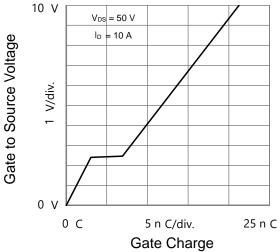
Drain Current
Drain to Source Resistance vs. Drain Currer



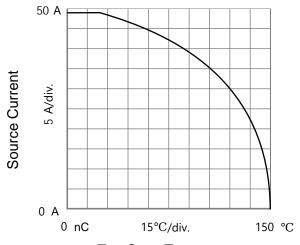
Drain to Source Voltage Capacitances



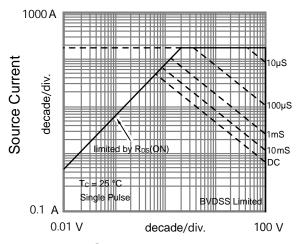
TYPICAL CHARACTERISTICS (T_C = 25 °C, unless otherwise noted)



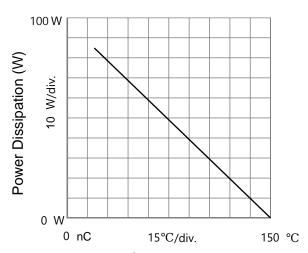
Gate to Source Voltage vs. GateCharge



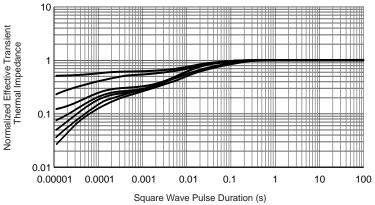
T_C - Case Temperature



Source to Drain Voltage Safe Operating Area, Junction-to-Case



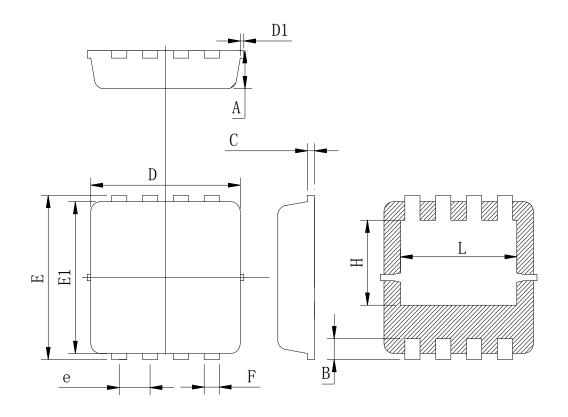
T_C - Case Temperature



Normalized Thermal Transient Impedance, Junction-to-Case



PDFN 3.3X3.3 PACKAGE OUTLINE



COMMON DIMENSIONS (UNITS OF MEASURE=MILLIMETER)

Symbol	Min	Тур	Max
А	0.600	0.775	1.000
В	0.20	0.38	0.55
С	0.05	0.15	0.40
D	3.10	3.25	3.50
D1	-	-	0.15
Е	3.15	3.35	3.50
E1	2.60	3.10	3.45
е	0.50	0.65	0.80
F	0.15	0.32	0.45
Н	1.25	1.73	2.10
L	2.20	2.45	2.85





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